

Search Notes

Application/Control No.

10/686,340

Examiner

Bryan Bui

Applicant(s)/Patent under
Reexamination

HAN ET AL.

Art Unit

2863

SEARCHED

Class	Subclass	Date	Examiner
702	57	3/21/2005	BB
	58		
	62		
	65		
	87		
370	189	3/21/2005	BB
	191		
	276		
	286		
	289		
	290		
379	291	3/21/2005	BB
	406.1		
	406.05		
	406.06		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	3/21/2005	BB